

100V N-Channel Power MOSFET

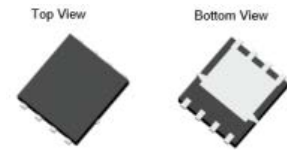
DESCRIPTION :

- Ultra-Low On-Resistance, $R_{DS(ON)}$
- Low Gate Charge
- 100% UIS Tested, 100% Rg Tested
- Pb-Free Lead Plating
- RoHS compliant
- AEC-Q101

V_{DS}	100V
$I_D @ V_{GS}=10V$	138A
$R_{DS(ON_Typ.) @ V_{GS}=10V}$	3.3m Ω

TYPICAL APPLICATIONS :

- Power Management
- Load Switch
- PWM Application



PDFN5x6-8L

MAXIMUM RATINGS (at $T_A = 25^\circ\text{C}$, unless otherwise specified)

Characteristic	Condition	Symbol	Value	Unit
Drain-Source Voltage		V_{DS}	100	V
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	$T_c=25^\circ\text{C}$ $T_c=100^\circ\text{C}$	I_D	138 98	A
Pulsed Drain Current ⁽¹⁾		I_{DM}	553	A
Avalanche Current ⁽²⁾		I_{AS}	68	A
Avalanche Energy ⁽²⁾		E_{AS}	231	mJ
Power dissipation	$T_c=25^\circ\text{C}$ $T_c=100^\circ\text{C}$	P_D	176 88	W
Junction & Storage temperature Range		T_J, T_{STG}	-55~+175	$^\circ\text{C}$

Notes : 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

2. The single-pulse measurement was taken under the following condition [$V_{DD}=50V, V_G=10V, L=100\mu\text{H}$] while its value is limited by $T_{JMAX} = 175^\circ\text{C}$

THERMAL CHARACTERISTICS

Characteristic	Condition	Symbol	Value	Unit
Thermal resistance,	Junction to Ambient Junction to Case	$R_{\theta JA}$ $R_{\theta JC}$	50 1.0	$^\circ\text{C}/\text{W}$

ELECTRICAL CHARACTERISTICS (at $T_J = 25\text{ }^\circ\text{C}$, unless otherwise specified)

Characteristic	Symbol	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage VGS = 0V, ID = 250uA	$V_{(BR)DSS}$	100			V
Zero Gate Voltage Drain Current VDS = 80 V, VGS = 0 V	I_{DSS}			1	uA
Gate-Source Leakage Current VGS = ± 20 V, VDS = 0V	I_{GSS}			± 100	nA
Gate-Source threshold voltage VDS = VGS, ID = 250uA	$V_{GS(th)}$	2.0	2.7	4.0	V
Drain-Source On-State Resistance VGS = 10V, ID = 20A	$R_{DS(on)}$		3.3	4.3	m Ω
Forward Transconductance VDS = 5V, ID = 20A	G_{FS}		3.3	4.3	S
Input capacitance f=1MHz, VDS=50 V, VGS=0 V	C_{iss}		3434		pF
Output capacitance f=1MHz, VDS=50 V, VGS=0 V	C_{oss}		906		pF
Reverse transfer capacitance f=1MHz, VDS=50 V, VGS=0 V	C_{rss}		14		pF
Gate Resistance VDS=0 V, VGS= 0V, f=1MHz	R_g		2.3		Ω
Total Gate Charge VDS= 50V, ID= 20A, VGS=10V / 6V	Q_G		57/38		nC
Gate to Source Charge VDS= 50V, ID= 20A, VGS= 0 to 10V	Q_{GS}		11		nC
Gate to Drain Charge VDS= 50V, ID= 20A, VGS= 0 to 10V	Q_{GD}		16.1		nC
Turn-on delay time VDS=50 V, VGS= 10V, $R_L=2.5\Omega$, $R_{GEN}=3\Omega$	$t_{d(ON)}$		14.1		ns
Rise time VDS=50 V, VGS= 10V, $R_L=2.5\Omega$, $R_{GEN}=3\Omega$	t_r		34		ns
Turn-off delay time VDS=50 V, VGS= 10V, $R_L=2.5\Omega$, $R_{GEN}=3\Omega$	$t_{d(OFF)}$		60		ns
Fall time VDS=50 V, VGS= 10V, $R_L=2.5\Omega$, $R_{GEN}=3\Omega$	t_f		50		ns

Body Diode

ELECTRICAL CHARACTERISTICS (at $T_J = 25\text{ }^\circ\text{C}$, unless otherwise specified)

Characteristic	Symbol	Min.	Typ.	Max.	Unit
Diode Forward Voltage $V_{GS} = 0V, I_S = 1A$	V_{SD}		0.7	1.0	V
Diode Continuous Current, $T_c=25^\circ\text{C}$	I_S			176	A
Revers Recovery Time $I_F=15A, dI_F/dt = 100A/us$	T_{rr}		59		ns
Revers Recovery Charge $I_F=15A, dI_F/dt = 100A/us$	Q_{rr}		62		nC

Typical Performance Characteristics

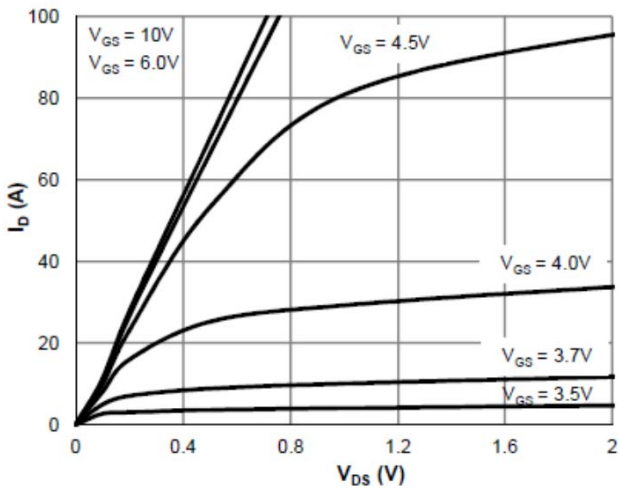


Figure 1. Output Characteristics

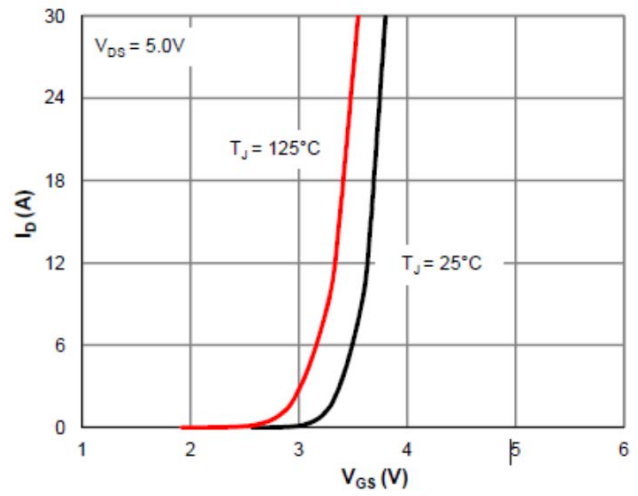


Figure 2. Typical Transfer Characteristics

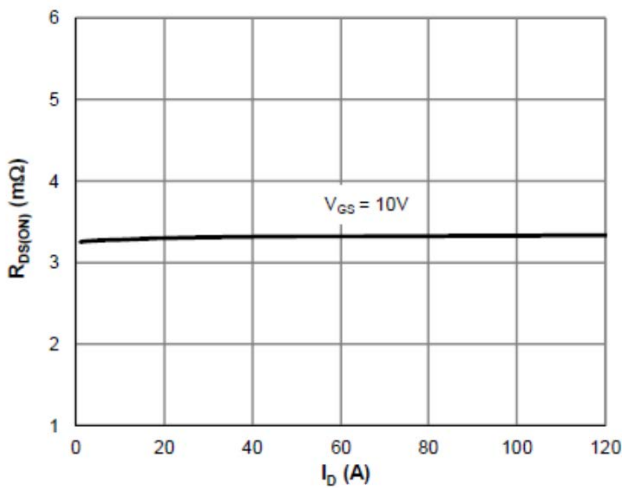


Figure 3. On-resistance vs. Drain Current

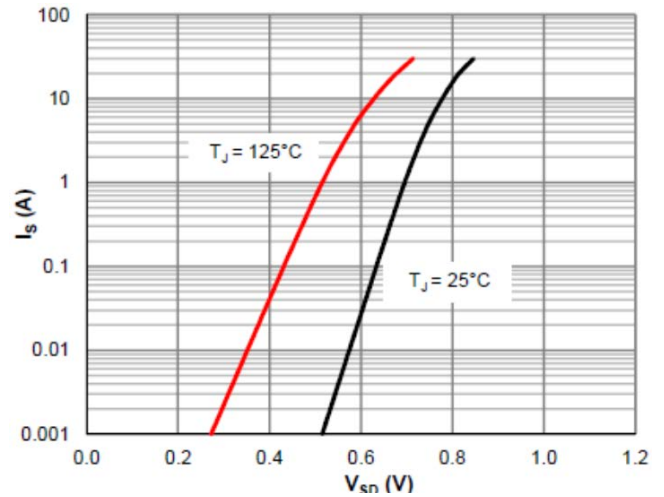


Figure 4. Body Diode Characteristics

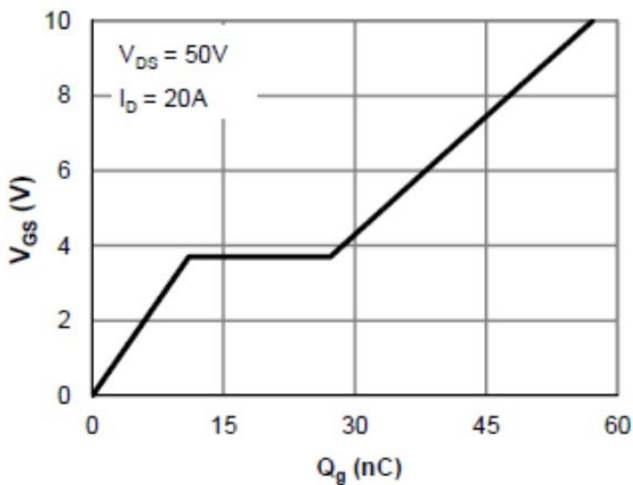


Figure 5. Gate Charge Characteristics

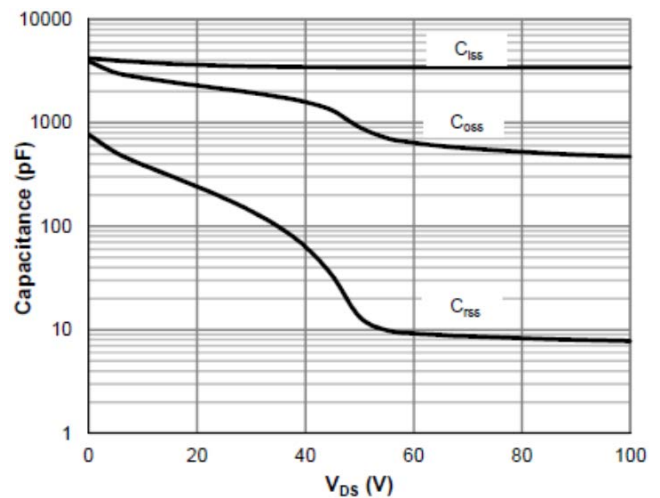


Figure 6. Capacitance Characteristics

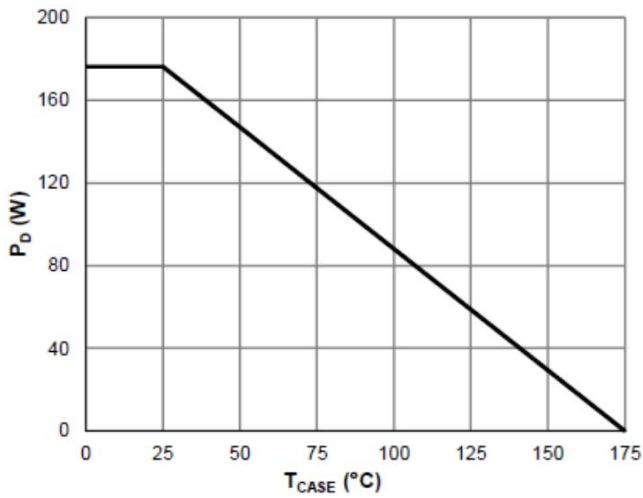


Figure 7. Power De-rating

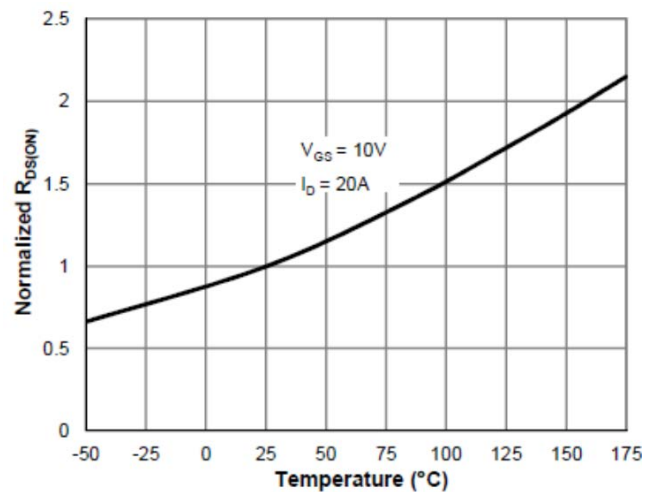


Figure 8. Normalized on Resistance vs. Junction Temperature

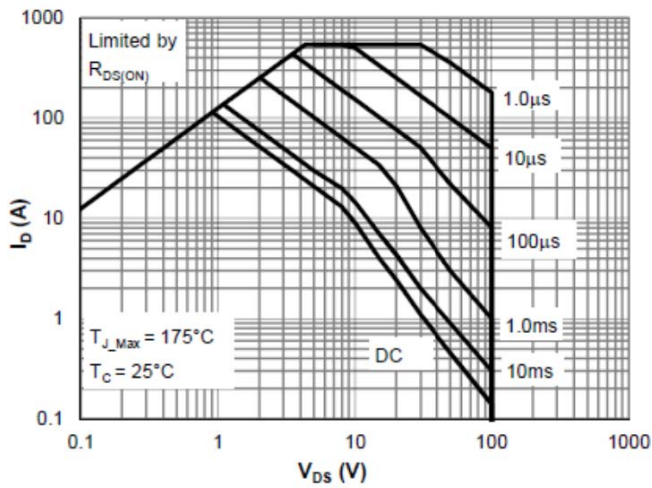


Figure 9. Maximum Safe Operating Area

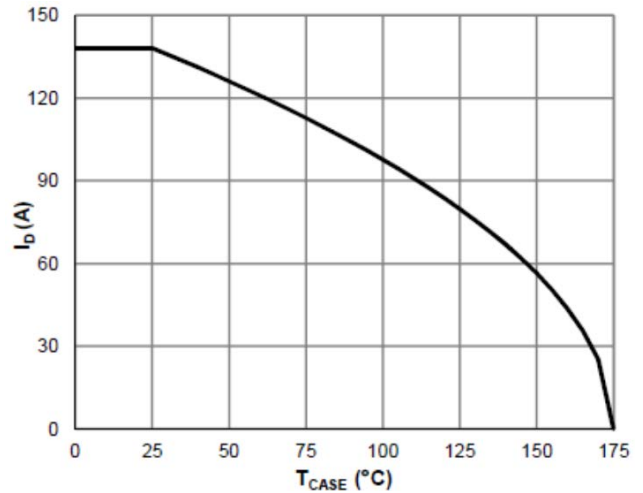


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

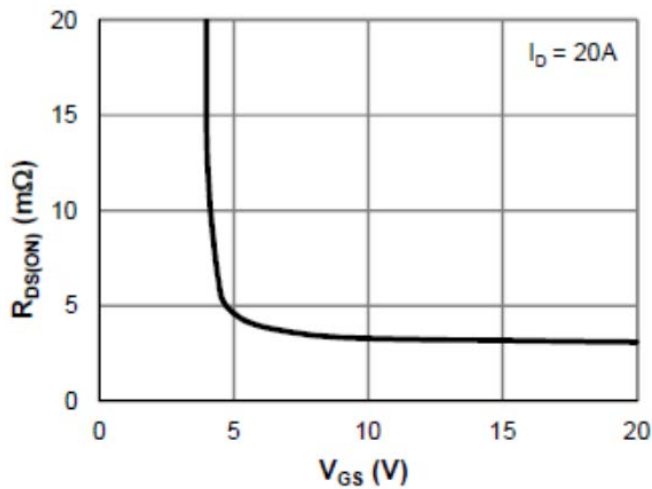


Figure 11. $R_{DS(ON)}$ vs. V_{GS}

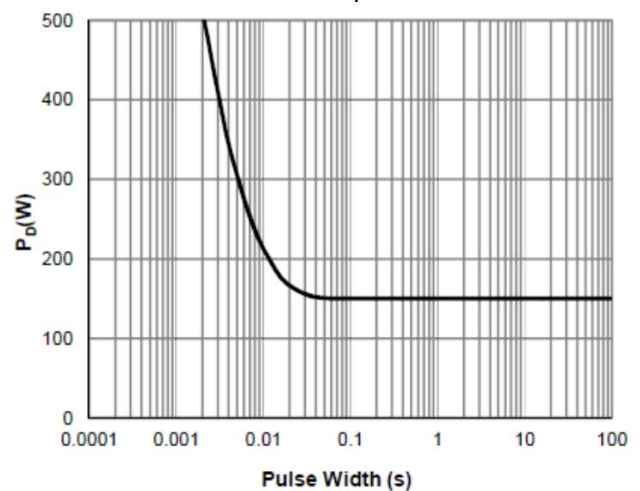


Figure 12. Single Pulse Power Rating, Junction to Case

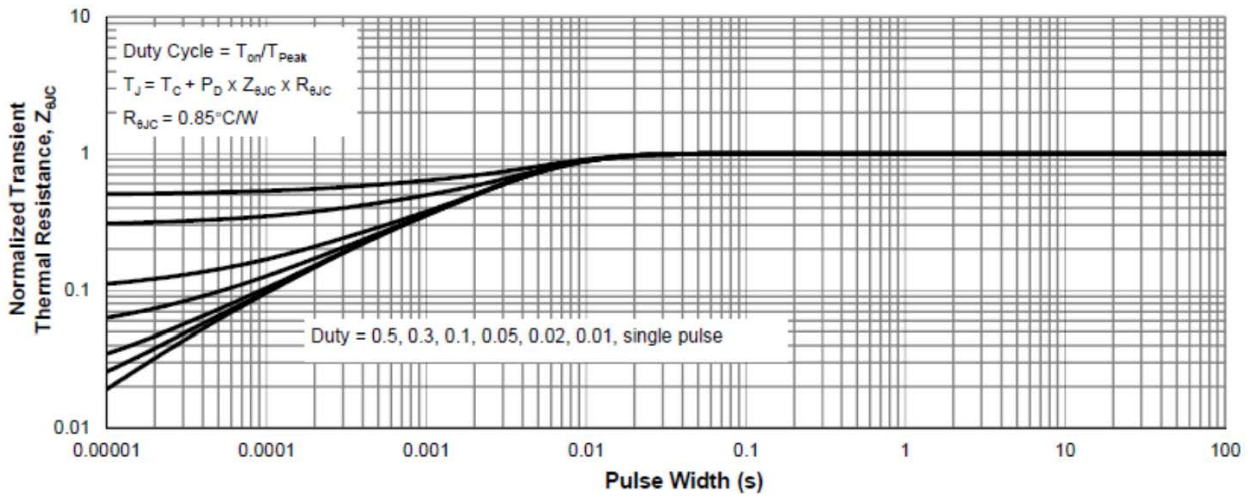
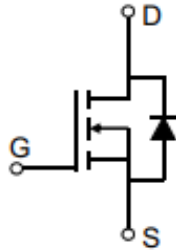
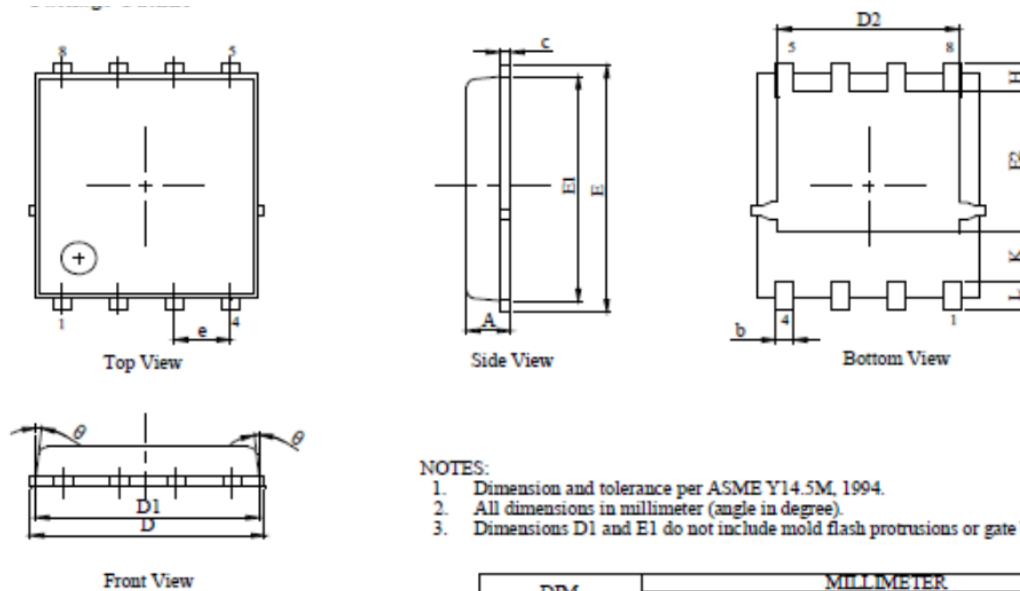


Figure 13. Normalized Maximum Transient Thermal Impedance

- Circuit diagram



• Package outlines :



NOTES:

1. Dimension and tolerance per ASME Y14.5M, 1994.
2. All dimensions in millimeter (angle in degree).
3. Dimensions D1 and E1 do not include mold flash protrusions or gate burrs.

DIM	MILLIMETER		
	MIN.	NOM.	MAX.
A	0.90	1.00	1.10
b	0.31	0.41	0.51
c	0.20	0.25	0.30
D	5.00	5.20	5.40
D1	4.95	5.05	5.15
D2	4.00	4.10	4.20
E	6.05	6.15	6.25
E1	5.50	5.60	5.70
E2	3.42	3.53	3.63
e	1.27BSC		
H	0.60	0.70	0.80
L	0.50	0.70	0.80
θ	-	-	10°

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